

# ALPHA & OMEGA AGD8252B1 / AGD8252B2

High Voltage Half-Bridge Gate Driver IC

### **General Description**

The AGD8252B1 / AGD8252B2 are 600V half-bridge gate driver ICs to control IGBTs and power MOS-transistors in full-bridge and 3-phase inverter systems. Due to specially designed common mode filter, it has an excellent ruggedness on transient voltage variation.



SOP-8L (Body: 5.0 x 4.0 x 1.5 mm)

#### **Features**

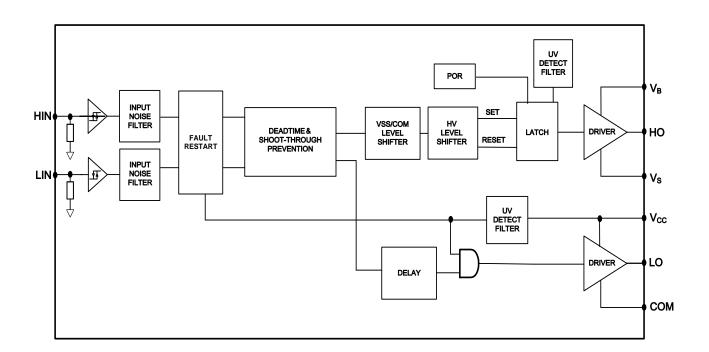
- Maximum blocking voltage +600V
- Output current: +200mA / -350mA (Typ.)
- · Matched propagation delay for both channels
- Shoot-through (cross-conduction) protection
- Under-voltage lockout protection (UVLO)
- 3.3V / 5V CMOS and TTL inputs logic compatible
- Input logic: Schmitt trigger receiver circuit (Active high)

### **Applications**

- Motor drives
- Home appliances
- IGBT and power MOS gate drivers for general purpose



### **Internal Block Diagram**

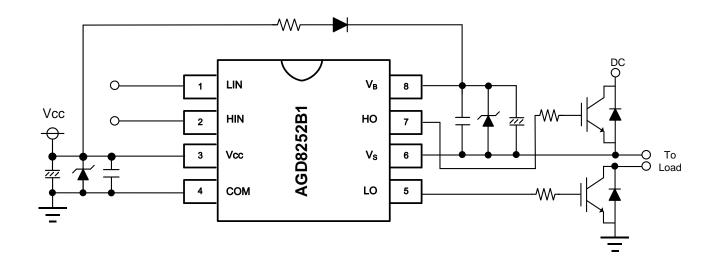


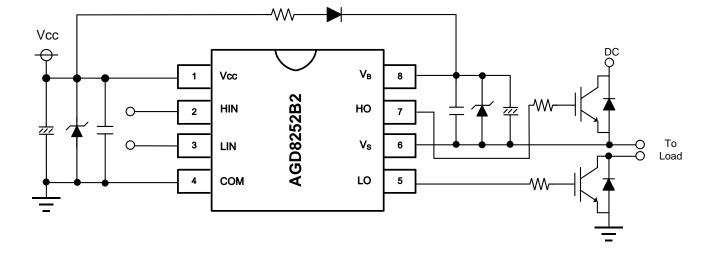


# **Ordering Information**

Part Number	Temperature Range	Package
AGD8252B1	-40°C to 125°C	SOP-8L
AGD8252B2	-40°C to 125°C	SOP-8L

# **Typical Application Circuit**

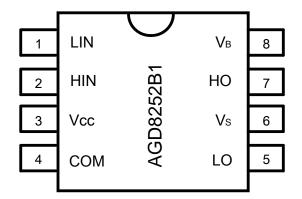


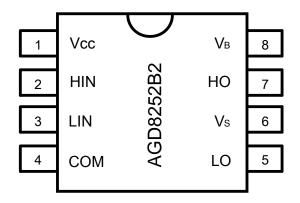


Rev. 1.1 October 2018 **www.aosmd.com** Page 2 of 9



# **Pin Configuration**





# **Pin Description**

Pin Name	Pin Function	
V <sub>CC</sub>	Low-Side Supply Voltage	
HIN	High-Side Logic Input	
LIN	Low-Side Logic Input	
СОМ	Power Ground	
LO	Low-Side Driver Output	
Vs	High-Side Floating Supply Offset Voltage	
НО	High-Side Driver Output	
V <sub>B</sub>	High-Side Floating Supply Voltage	

# **Absolute Maximum Ratings**

Absolute maximum ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute values referenced to V<sub>SS</sub>, unless otherwise stated in the table.

Symbol	Parameter	Min. Max.		Units
V <sub>CC</sub>	Low-Side Supply Voltage	-0.3	20 (1)	
V <sub>IN</sub>	Logic Input Voltage (LIN, HIN)	V <sub>SS</sub> -0.3	V <sub>SS</sub> -0.3 V <sub>CC</sub> +0.3	
V <sub>B</sub>	High-Side Floating Supply Voltage	-0.3	-0.3 620	
Vs	High-Side Floating Supply Offset Voltage	V <sub>B</sub> -20 <sup>(1)</sup>	V <sub>B</sub> +0.3	V
V <sub>HO</sub>	High-Side Driver Output Voltage	V <sub>S</sub> -0.3	V <sub>B</sub> +0.3	
$V_{LO}$	Low-Side Driver Output Voltage	COM-0.3	V <sub>CC</sub> +0.3	
СОМ	Power Ground	V <sub>CC</sub> -25	V <sub>CC</sub> +0.3	
dV <sub>S</sub> /dt	Vs Offset Voltage Slew Rate (2)	- 50		V/ns
PW <sub>HIN</sub>	High-Side Input Pulse Width	500 -		ns
P <sub>D</sub>	Package Power Dissipation @ T <sub>A</sub> ≤25°C	- 0.75		W
R <sub>thJA</sub>	Thermal Resistance, Junction to Ambient	- 150		°C/W
TJ	Junction Temperature	- 150		
Ts	Storage Temperature		150	°C
TL	Solder Reflow Condition (10 seconds)	-	300	
ESD	Human Body Model	2		kV

#### Notes:

- 1. An internal 20V zener diode is integrated to clamp each supply voltage.
- 2. Not subject of production test, verified by characterization.



### **Recommended Operating Ratings**

The device is not guaranteed to operate beyond the Recommended Operating Conditions. All voltage parameters are absolute voltages referenced to  $V_{SS}$ , unless otherwise specified. The offset rating is tested with supplies of  $(V_{CC}\text{-COM}) = (V_B\text{-}V_S) = 15V$ .

Symbol	Parameter	Min.	Max.	Units
V <sub>CC</sub>	Low-Side Supply Voltage	13.2	20	
V <sub>IN</sub>	Logic Input Voltage (LIN, HIN)	V <sub>SS</sub>	V <sub>SS</sub> +5	
V <sub>B</sub>	High-Side Floating Supply Voltage	V <sub>S</sub> +13.2	V <sub>S</sub> +20	
Vs	High-Side Floating Supply Offset Voltage (3)		600	V
V <sub>S</sub> (t)	Transient High-Side Floating Supply Voltage (4)	-50	600	V
$V_{HO}$	High-Side Driver Output Voltage	Vs	V <sub>B</sub>	
$V_{LO}$	Low-Side Driver Output Voltage		V <sub>CC</sub>	
COM	Power Ground	-5	5	
T <sub>A</sub>	Ambient Temperature	-40	125	°C

#### Notes:

- 3. Logic operation for  $V_S$  of -6V to 600V. Logic state held for  $V_S$  of -6V to -V<sub>BS</sub>.
- 4. Operational for transient negative  $V_S$  of  $V_{SS}$ -50V with a 50ns pulse width, which is guaranteed by design.

#### Static Electrical Characteristics

 $V_{CC} = V_{BS} = 15V$ .  $T_A = 25$ °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
UV <sub>CC+</sub>	V <sub>CC</sub> Under-Voltage Positive Going Threshold		10.8	11.9	13.0	
UV <sub>CC</sub> -	V <sub>CC</sub> Under-Voltage Negative Going Threshold		10.3	11.4	12.5	
UV <sub>CChys</sub>	V <sub>CC</sub> Under-Voltage Hysteresis		-	0.5	-	V
UV <sub>BS+</sub>	V <sub>BS</sub> Under-Voltage Positive Going Threshold		10.0	11.0	12.0	
UV <sub>BS</sub> -	V <sub>BS</sub> Under-Voltage Negative Going Threshold		9.0	10.0	11.0	
UV <sub>BShys</sub>	V <sub>BS</sub> Under-Voltage Hysteresis		-	1.0	-	
I <sub>LK</sub>	High-Side Floating Supply Leakage Current	V <sub>B</sub> =V <sub>S</sub> =600V	-	-	50	μA
I <sub>QBS</sub>	Quiescent V <sub>BS</sub> Supply Current	V <sub>IN</sub> =0V	-	70	120	μA
Iqcc	Quiescent V <sub>CC</sub> Supply Current	(all inputs are in the off state)	-	0.3	1	mA
V <sub>OH</sub>	High Level Output Voltage Drop, V <sub>BIAS</sub> -V <sub>O</sub>	I <sub>O</sub> =20mA, V <sub>IN</sub> =5V	-	0.9	1.4	V
V <sub>OL</sub>	Low Level Output Voltage Drop, Vo	I <sub>O</sub> =20mA, V <sub>IN</sub> =0V	-	0.4	0.6	V
I <sub>O+</sub>	Output High Short Circuit Pulsed Current	V <sub>O</sub> =0V, V <sub>IN</sub> =5V, PW≤10μs	120	200	-	Λ
I <sub>O</sub> -	Output Low Short Circuit Pulsed Current	V <sub>O</sub> =15V, V <sub>IN</sub> =0V, PW≤10μs	250	350	-	mA
V <sub>IH</sub>	High Level Input Voltage		2.5	-	-	V
V <sub>IL</sub>	Low Level Input Voltage		-	-	0.8	V
I <sub>HIN+</sub>	Input Bias Current	V <sub>HIN</sub> =5V	-	650	850	
I <sub>HIN-</sub>	Input Bias Current	V <sub>HIN</sub> =0V	-	-	1	
I <sub>LIN+</sub>	Input Bias Current	V <sub>LIN</sub> =5V	-	650	850	μA
I <sub>LIN-</sub>	Input Bias Current	V <sub>LIN</sub> =0V	-	-	1	

Rev. 1.1 October 2018 **www.aosmd.com** Page 4 of 9



# **Dynamic Electrical Characteristics**

 $V_{CC} = V_{BS} = 15V$ ,  $C_L = 1000 pF$  and  $T_A = 25$ °C unless otherwise specified.

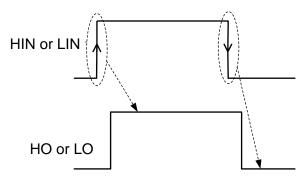
Symbol	Definition Conditions		Min.	Тур.	Max.	Units
t <sub>ON</sub>	Turn-On Propagation Delay		400	530	750	
t <sub>OFF</sub>	Turn-Off Propagation Delay		400	530	750	
t <sub>R</sub>	Turn-On Rise Time	V <sub>IN</sub> =0V or 5V		125	190	
t <sub>F</sub>	Turn-Off Fall Time		-	50	75	
t <sub>IN,FLT</sub>	Input Filter Time (LIN, HIN) (5)		200	350	510	ns
DT	Dead Time <sup>(6)</sup>	V <sub>IN</sub> =0V or 5V without External Dead Time	190	275	420	
MT	Matching Delay Time (t <sub>ON</sub> , t <sub>OFF</sub> )	t <sub>ON(HO)</sub> - t <sub>ON(LO)</sub>   or  t <sub>OFF(HO)</sub> - t <sub>OFF(LO)</sub>	-	-	50	
PM	Output Pulse Width Matching (7)	Input Pulse Width=10µs	-	-	75	

#### Notes:

- 5. The minimum width of the input pulse is recommended to exceed 500ns to ensure the filtering time of the input filter is exceeded.
- 6. Please refer to 'Dead Time' definition of 'Function Diagram'.
- 7. PM is defined as |(Input Pulse Width) (Output Pulse Width)|.



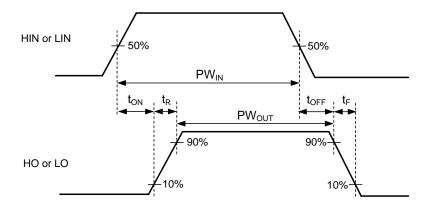
# **Output Activation**



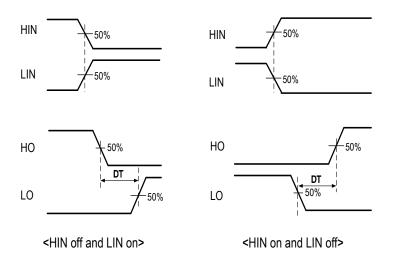
HIN	LIN	но	LO
Н	L	L H L	
L	Н	L	Н

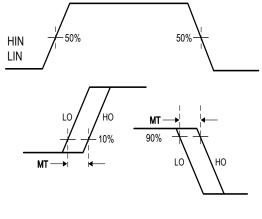
Note: Output signal (HO or LO) is triggered by the edge of input signal.

# **Input / Output Timing Diagram**



### **Dead Time Activation**



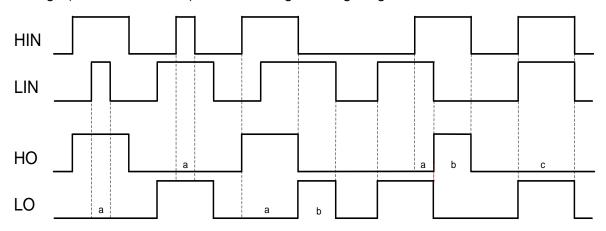


<Delay Matching Waveform Definition>



### **Function Timing Diagram**

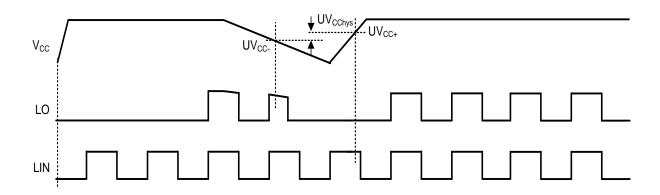
A. Shoot-Through (Cross-Conduction) Protection Logic Timing Diagram



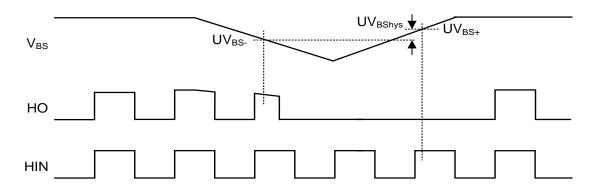
#### Notes:

- a. When one output (high or low side) is turned on, the other side turn-on input is ignored.
- If both outputs are changed simultaneously, the turn-on activation is done by the internal dead time of 275ns typ. (For more information, please refer to below 'Dead Time' section.)
- c. When high-side (HIN) and low-side (LIN) have turn-on inputs at the same time, low-side (LIN) has the priority.

### B. V<sub>CC</sub> Supply Under-Voltage (UV) Lockout Timing Diagram



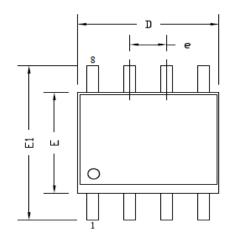
# C. V<sub>BS</sub> Supply Under-Voltage (UV) Lockout Timing Diagram

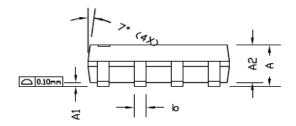


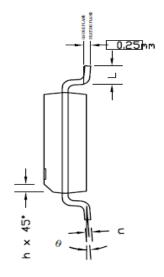
Rev. 1.1 October 2018 **www.aosmd.com** Page 7 of 9



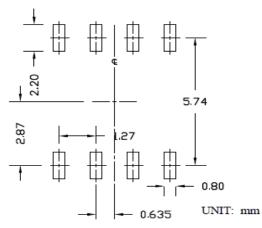
### Package Dimensions, SOP-8L







#### RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
STMBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	1.35	1.65	1.75	0.053	0.065	0.069
A1	0.10	0.15	0.25	0.004	0.006	0.010
A2	1.25	1.50	1.65	0.049	0.059	0.065
ь	0.31	0.41	0.51	0.012	0.016	0.020
С	0.17	0.20	0.25	0.007	0.008	0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
E	3.80	3.90	4.00	0.150	0.154	0.157
e	1.27 BSC			0	.050 BSC	;
E1	5.80	6.00	6.20	0.228	0.236	0.244
h	0.25	0.30	0.50	0.010	0.012	0.020
L	0.40	0.69	1.27	0.016	0.027	0.050
θ	0°	4°	8°	0°	4°	8°

#### NOTE

- 1. ALL DIMENSIONS ARE IN MILLMETERS.
- 2. DIMENSIONS ARE INCLUSIVE OF PLATING.
- PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
  MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 4. DIMENSION L IS MEASURED IN GAUGE PLANE.
- CONTROLLING DIMENSION IS MILLIMETER.
  CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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